

#### **Description**

The AP50N03AD uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

#### **General Features**

V<sub>DS</sub>=30V I<sub>D</sub> =50A

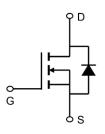
 $R_{DS(ON)} < 13m\Omega$  @  $V_{GS}=10V$  (Type:  $9.5m\Omega$ )

#### **Application**

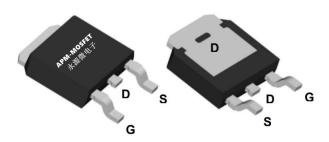
Battery protection

Load switch

Uninterruptible power supply







#### **Package Marking and Ordering Information**

| 0          | •         |                     |          |
|------------|-----------|---------------------|----------|
| Product ID | Pack      | Marking             | Qty(PCS) |
| AP50N03AD  | TO-252-3L | AP50N03AD XXXX YYYY | 2500     |

#### Absolute Maximum Ratings (T<sub>C</sub>=25°Cunless otherwise noted)

| Symbol  | Parameter   | Rating     | Units                                     |  |   |
|---|---|------------|---|--|---|
| VDS   | Drain-Source Voltage  | 30         | V   |  |   |
| Vgs   | Gate-Source Voltage   | ±20        | V   |  |   |
| I <sub>D</sub> @T <sub>C</sub> =25°C                | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>              | 50         | А   |  |   |
| I <sub>D</sub> @T <sub>C</sub> =100°C               | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>              | 30         | А   |  |   |
| Ірм   | Pulsed Drain Current <sup>2</sup>   | 112        | А   |  |   |
| EAS   | EAS Single Pulse Avalanche Energy <sup>3</sup>                            |            | mJ  |  |   |
| las   | I <sub>AS</sub> Avalanche Current   |            | А   |  |   |
| P <sub>D</sub> @T <sub>C</sub> =25°C                | P <sub>D</sub> @T <sub>C</sub> =25°C Total Power Dissipation <sup>4</sup> |            | W   |  |   |
| P <sub>D</sub> @T <sub>A</sub> =25°C                | P <sub>D</sub> @T <sub>A</sub> =25°C Total Power Dissipation⁴             |            | Total Power Dissipation <sup>4</sup> 2.42 |  | W |
| Тѕтс  | Storage Temperature Range   | -55 to 175 | °C  |  |   |
| T <sub>J</sub> Operating Junction Temperature Range |   | -55 to 175 | °C  |  |   |
| Reja  | Thermal Resistance Junction-Ambient <sup>1</sup>                          | 62         | °C/W                                      |  |   |
| ReJC  | R <sub>θ</sub> JC Thermal Resistance Junction-Case <sup>1</sup>           |            | °C/W                                      |  |   |



#### Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

| Symbol                 | Parameter Conditions   |   | Min. | Тур.   | Max. | Unit  |  |
|------------------------|--|---|------|--------|------|-------|--|
| BVDSS                  | Drain-Source Breakdown Voltage                               | V <sub>GS</sub> =0V , I <sub>D</sub> =250uA                                 | 30   | 32     |      | V     |  |
| △BVDSS/△TJ             | BVDSS Temperature Coefficient                                | ature Coefficient Reference to 25°C , I <sub>D</sub> =1mA                   |      | 0.0193 |      | V/°C  |  |
|                        |  | V <sub>GS</sub> =10V , I <sub>D</sub> =30A                                  |      | 9.5    | 13   | mO.   |  |
| RDS(ON)                | Static Drain-Source On-Resistance <sup>2</sup>               | V <sub>GS</sub> =4.5V , I <sub>D</sub> =15A                                 |      | 11     | 18   | mΩ    |  |
| VGS(th)                | Gate Threshold Voltage                                       | V V I 050 A   | 1.2  | 1.6    | 2.5  | V     |  |
| $\triangle V_{GS(th)}$ | V <sub>GS(th)</sub> Temperature Coefficient                  | V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA                    |      | -3.97  |      | mV/°C |  |
| IDSS                   | Drain Course Leakage Current                                 | V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C           |      |        | 1    |       |  |
| נפטו                   | Drain-Source Leakage Current                                 | V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C           |      |        | 5    | - uA  |  |
| IGSS                   | Gate-Source Leakage Current                                  | V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V                                 |      |        | ±100 | nA    |  |
| gfs                    | Forward Transconductance                                     | V <sub>DS</sub> =5V , I <sub>D</sub> =30A                                   |      | 34     |      | S     |  |
| Rg                     | Gate Resistance  | V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz                          |      | 1.8    |      | Ω     |  |
| Qg                     | Total Gate Charge (4.5V)                                     |   |      | 9.8    |      |       |  |
| $Q_{\mathrm{gs}}$      | Gate-Source Charge   | V <sub>DS</sub> =15V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =15A          |      | 4.2    |      | nC    |  |
| $Q_{gd}$               | Gate-Drain Charge  |   |      | 3.6    |      |       |  |
| Td(on)                 | Turn-On Delay Time   | \/ 45\/ \/ 40\/   |      | 4      |      |       |  |
| Tr                     | Rise Time  | $V_{DD}$ =15V , $V_{GS}$ =10V $R_{G}$ =3.3 $\Omega$                         |      | 8      |      | no.   |  |
| Td(off)                | Turn-Off Delay Time  | I <sub>D</sub> =15A   |      | 31     |      | ns    |  |
| Tf                     | Fall Time  | 10-104  |      | 4      |      |       |  |
| Ciss                   | Input Capacitance  |   |      | 940    |      |       |  |
| Coss                   | Output Capacitance   | $V_{DS}$ =15V , $V_{GS}$ =0V , f=1MHz                                       |      | 131    |      | pF    |  |
| Crss                   | Reverse Transfer Capacitance                                 |   |      | 109    |      |       |  |
| Is                     | Continuous Source Current <sup>1,5</sup>                     | \/ -\/ -0\/ Fares Current   |      |        | 43   | Α     |  |
| ISM                    | Pulsed Source Current <sup>2,5</sup>                         | e Current <sup>2,5</sup> V <sub>G</sub> =V <sub>D</sub> =0V , Force Current |      |        | 112  | Α     |  |
| VSD                    | Diode Forward Voltage <sup>2</sup>                           | V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C             |      |        | 1    | V     |  |
| t <sub>rr</sub>        | Reverse Recovery Time  | IF=30A , dI/dt=100A/μs ,  |      | 8.5    |      | nS    |  |
| Q <sub>rr</sub>        | Q <sub>rr</sub> Reverse Recovery Charge T <sub>J</sub> =25°C |   |      | 2.2    |      | nC    |  |

#### Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2、 The data tested by pulsed , pulse width  $\leqq 300 us$  , duty cycle  $\leqq 2\%$
- 3. The EAS data shows Max. rating . The test condition is VDD=25V,VGS=10V,L=0.1Mh,IAS=22A  $\,$
- 4、The power dissipation is limited by 175°C junction temperature
- 5、The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.



#### **Typical Characteristics**

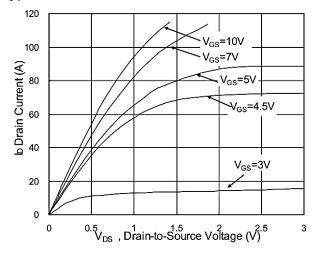


Fig.1 Typical Output Characteristics

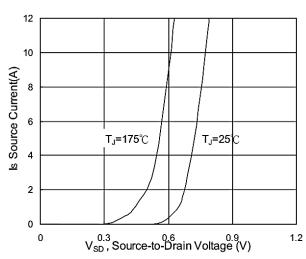


Fig.3 Forward Characteristics of Reverse

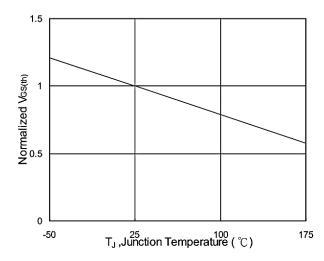


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$ 

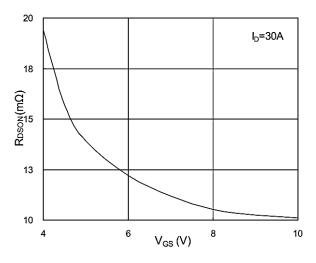


Fig.2 On-Resistance vs. G-S Voltage

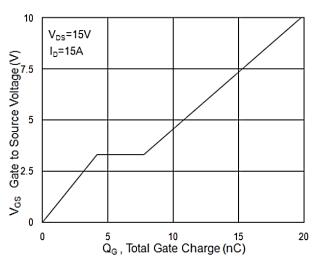


Fig.4 Gate-Charge Characteristics

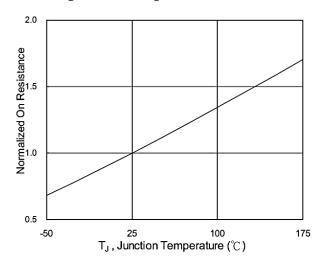
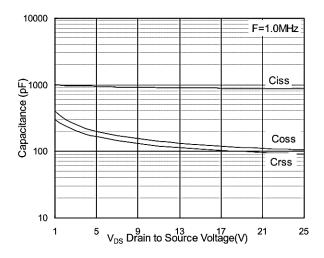


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>







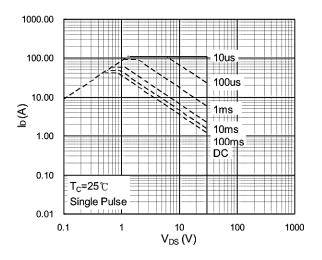


Fig.7 Capacitance

Fig.8 Safe Operating Area

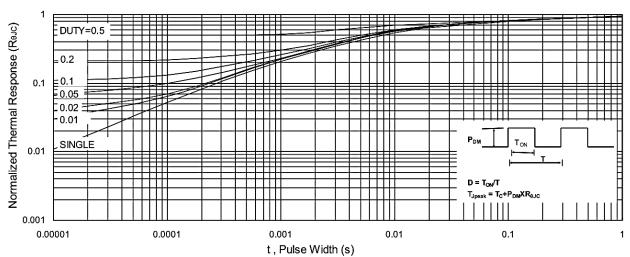


Fig.9 Normalized Maximum Transient Thermal Impedance

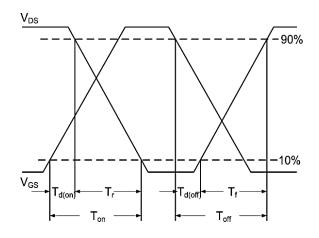


Fig.10 Switching Time Waveform

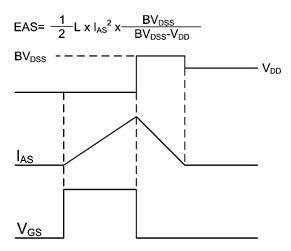
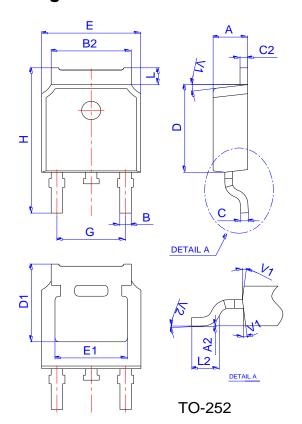


Fig.11 Unclamped Inductive Switching Waveform

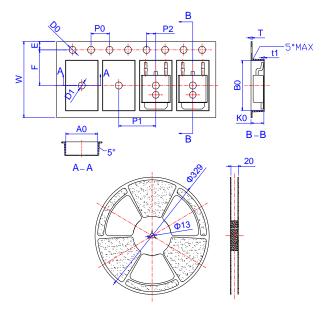


# Package Mechanical Data:TO-252-3L



|      | Dimensions  |      |       |          |      |       |
|------|-------------|------|-------|----------|------|-------|
| Ref. | Millimeters |      |       | Inches   |      |       |
|      | Min.        | Тур. | Max.  | Min.     | Тур. | Max.  |
| Α    | 2.10        |      | 2.50  | 0.083    |      | 0.098 |
| A2   | 0           |      | 0.10  | 0        |      | 0.004 |
| В    | 0.66        |      | 0.86  | 0.026    |      | 0.034 |
| B2   | 5.18        |      | 5.48  | 0.202    |      | 0.216 |
| С    | 0.40        |      | 0.60  | 0.016    |      | 0.024 |
| C2   | 0.44        |      | 0.58  | 0.017    |      | 0.023 |
| D    | 5.90        |      | 6.30  | 0.232    |      | 0.248 |
| D1   | 5.30REF     |      |       | 0.209REF |      |       |
| E    | 6.40        |      | 6.80  | 0.252    |      | 0.268 |
| E1   | 4.63        |      |       | 0.182    |      |       |
| G    | 4.47        |      | 4.67  | 0.176    |      | 0.184 |
| Н    | 9.50        |      | 10.70 | 0.374    |      | 0.421 |
| L    | 1.09        |      | 1.21  | 0.043    |      | 0.048 |
| L2   | 1.35        |      | 1.65  | 0.053    |      | 0.065 |
| V1   |             | 7°   |       |          | 7°   |       |
| V2   | 0°          |      | 6°    | 0°       |      | 6°    |

# **Reel Spectification-TO-252**



| Dimension |             |       | ensions | sions  |       |       |
|-----------|-------------|-------|---------|--------|-------|-------|
| Ref.      | Millimeters |       |         | Inches |       |       |
|           | Min.        | Тур.  | Max.    | Min.   | Тур.  | Max.  |
| W         | 15.90       | 16.00 | 16.10   | 0.626  | 0.630 | 0.634 |
| E         | 1.65        | 1.75  | 1.85    | 0.065  | 0.069 | 0.073 |
| F         | 7.40        | 7.50  | 7.60    | 0.291  | 0.295 | 0.299 |
| D0        | 1.40        | 1.50  | 1.60    | 0.055  | 0.059 | 0.063 |
| D1        | 1.40        | 1.50  | 1.60    | 0.055  | 0.059 | 0.063 |
| P0        | 3.90        | 4.00  | 4.10    | 0.154  | 0.157 | 0.161 |
| P1        | 7.90        | 8.00  | 8.10    | 0.311  | 0.315 | 0.319 |
| P2        | 1.90        | 2.00  | 2.10    | 0.075  | 0.079 | 0.083 |
| A0        | 6.85        | 6.90  | 7.00    | 0.270  | 0.271 | 0.276 |
| В0        | 10.45       | 10.50 | 10.60   | 0.411  | 0.413 | 0.417 |
| K0        | 2.68        | 2.78  | 2.88    | 0.105  | 0.109 | 0.113 |
| T         | 0.24        |       | 0.27    | 0.009  |       | 0.011 |
| t1        | 0.10        |       |         | 0.004  |       |       |
| 10P0      | 39.80       | 40.00 | 40.20   | 1.567  | 1.575 | 1.583 |





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# AP50N03AD

# **30V N-Channel Enhancement Mode MOSFET**

| Edition | Date     | Change          |
|---------|----------|-----------------|
| Rve1.0  | 2020/5/1 | Initial release |

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